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Title: Observing and Modeling Hot Spots in Individual Explosive Crystals with Shock Compression Microscopy

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Observing and Modeling Hot Spots in Individual Explosive Crystals with Shock Compression Microscopy

Belinda Pacheco Johnson

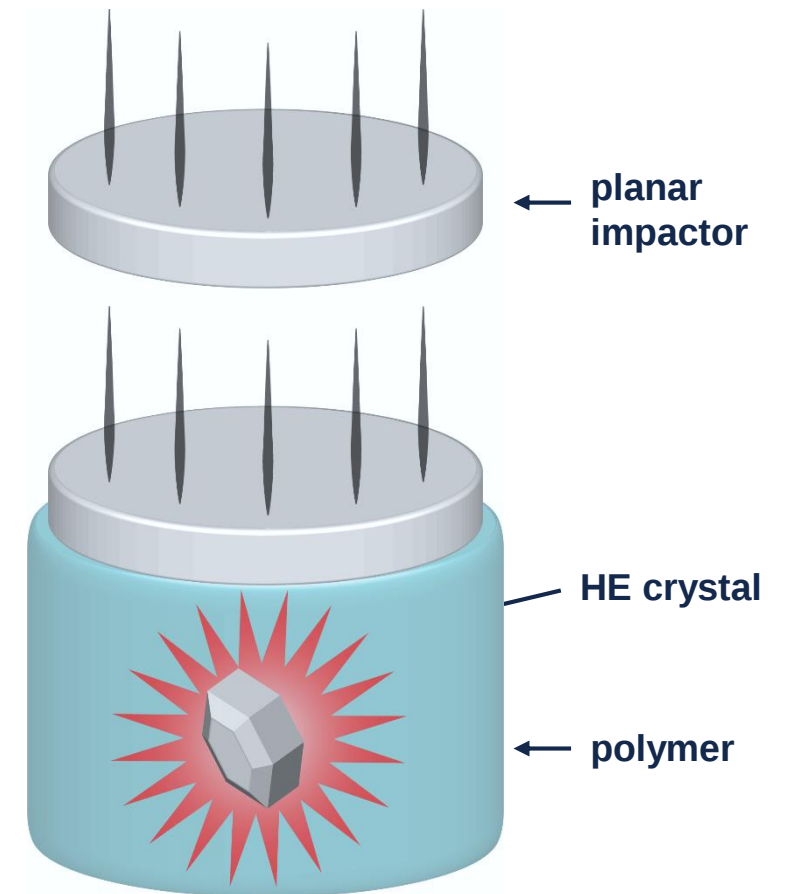
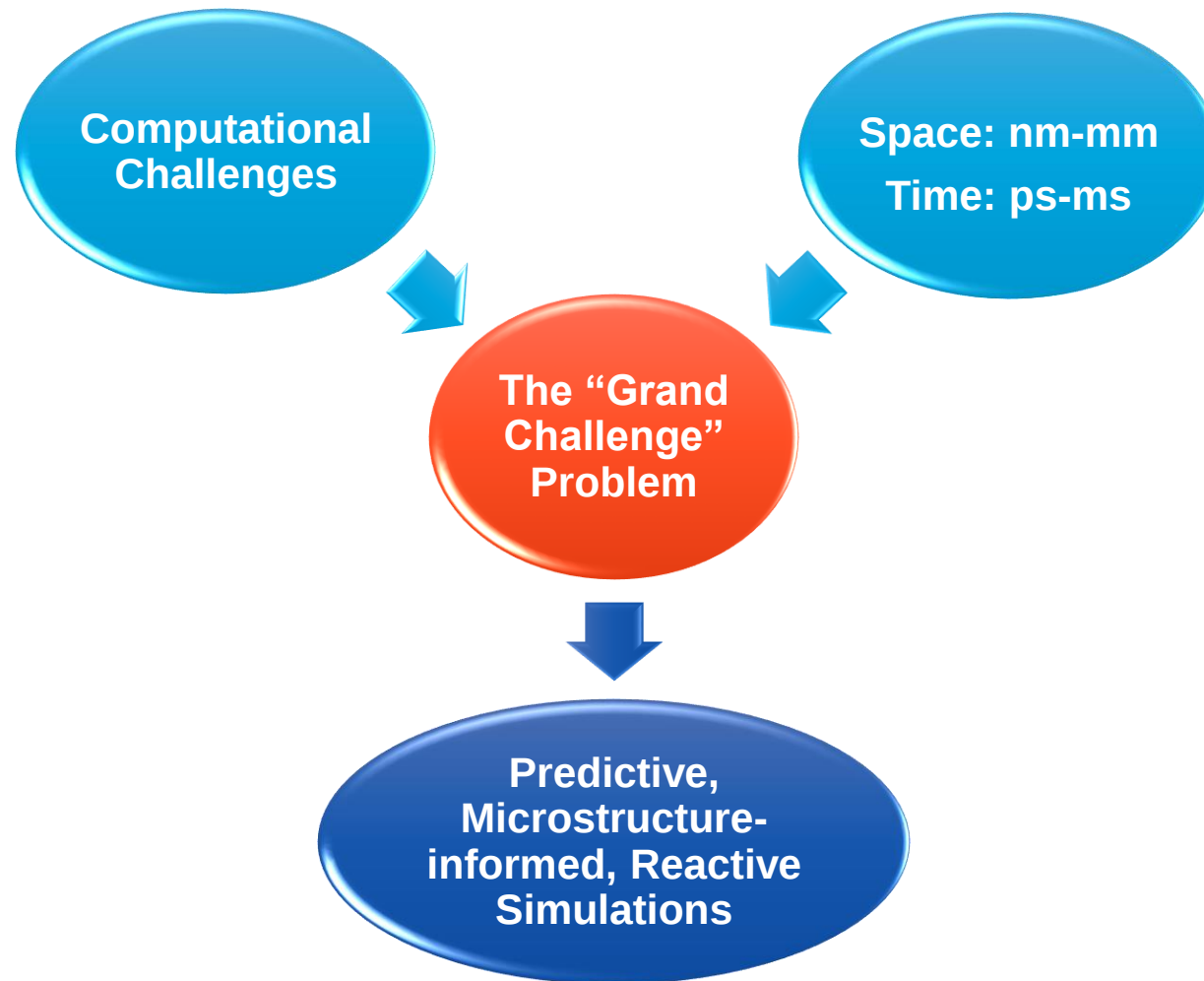
Dr. Xuan Zhou, Hoya Ihara, Prof. Prof. Dana D. Dlott
Shobhan Roy, Yen Nguyen, Prof. H.S. Udaykumar (University of Iowa)

GSCCM Virtual Seminar
December 7, 2021

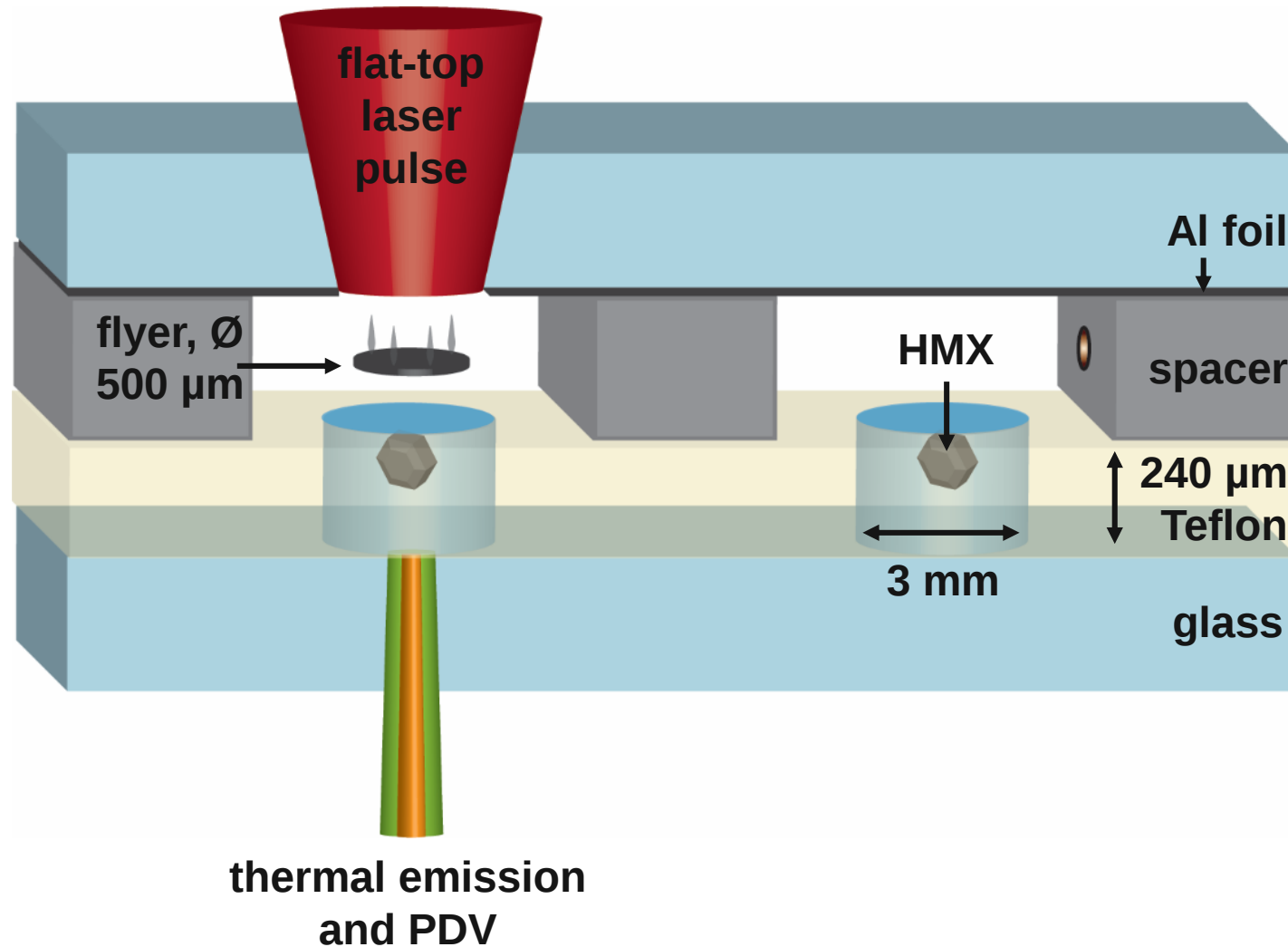


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The “Grand Challenge” Problem



Experimental Concept



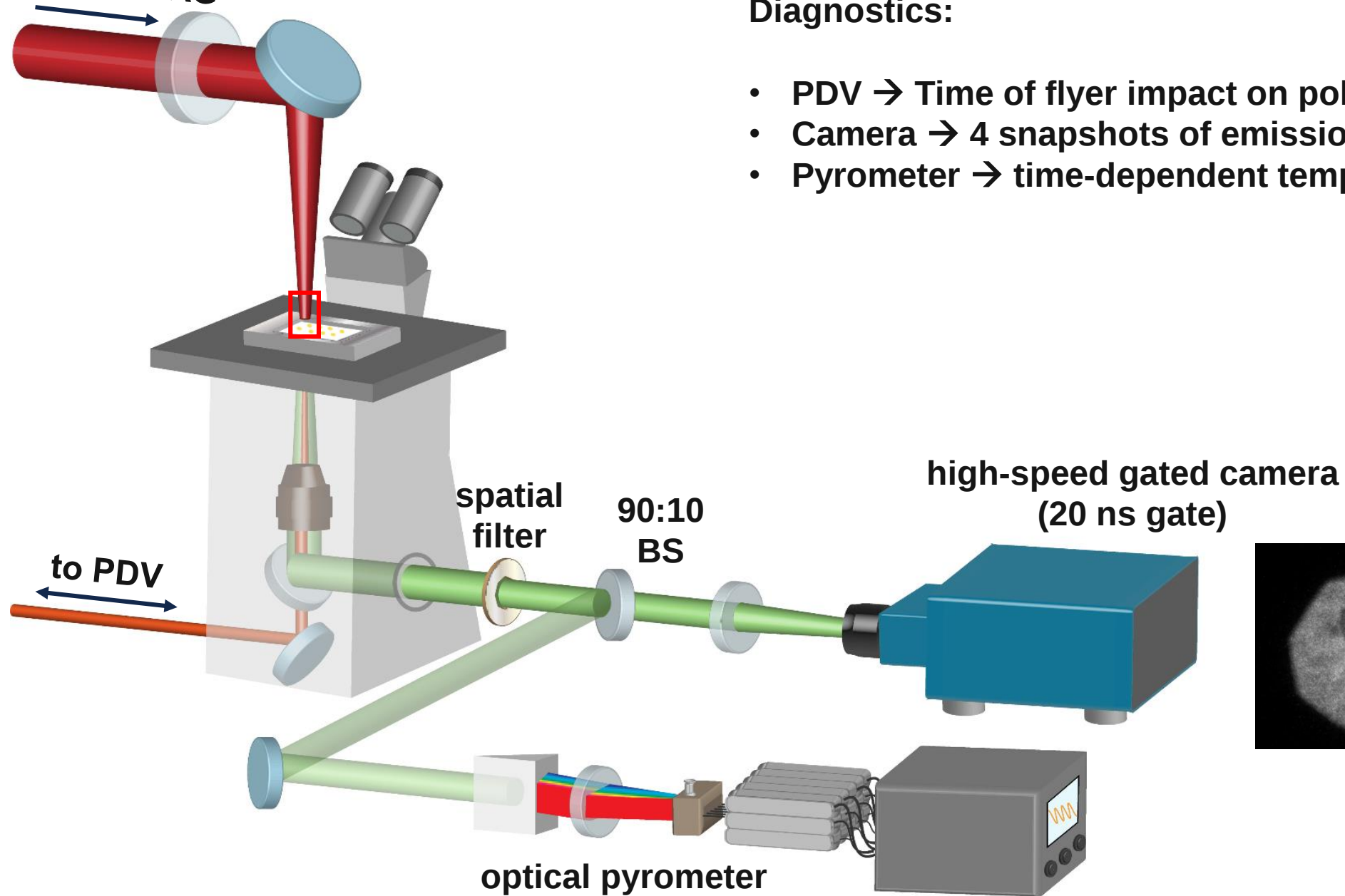
Variables:

- Single vs. defective crystals
- Impact velocity

$U_p = 1.8\text{--}3.0$ km/s (polymer)

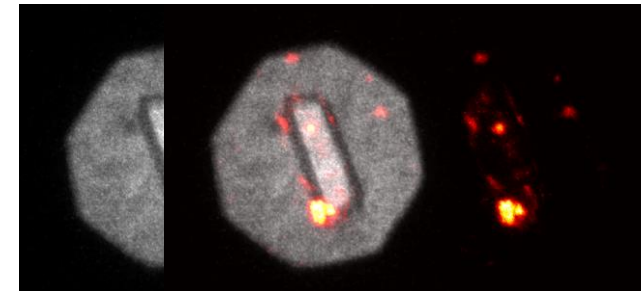
Pressures: 16-34 GPa (crystal)

1064 nm Nd:YAG



Diagnostics:

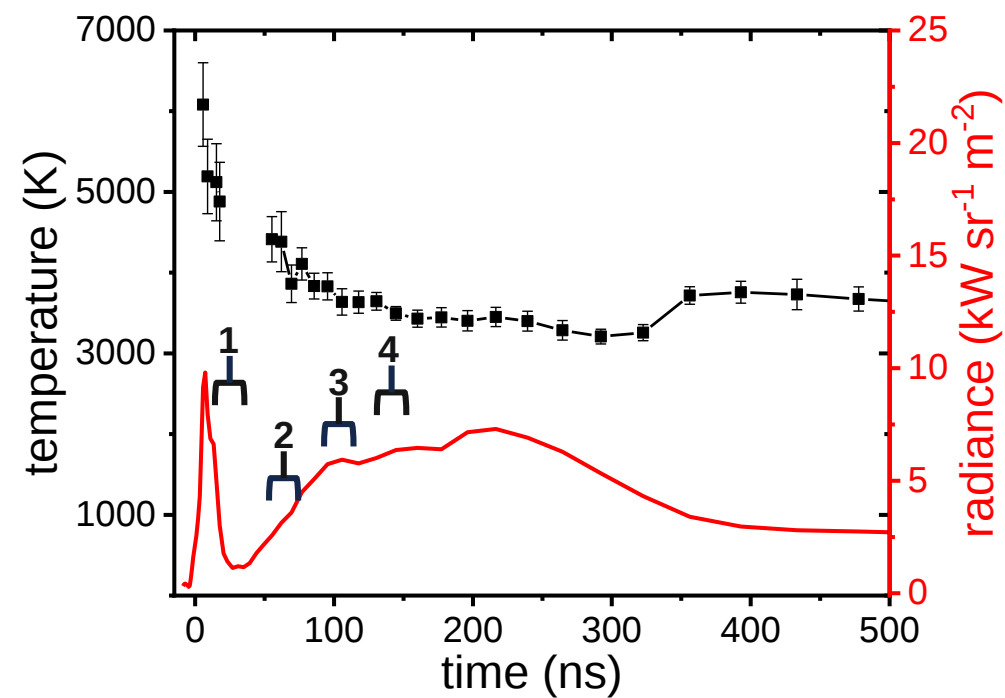
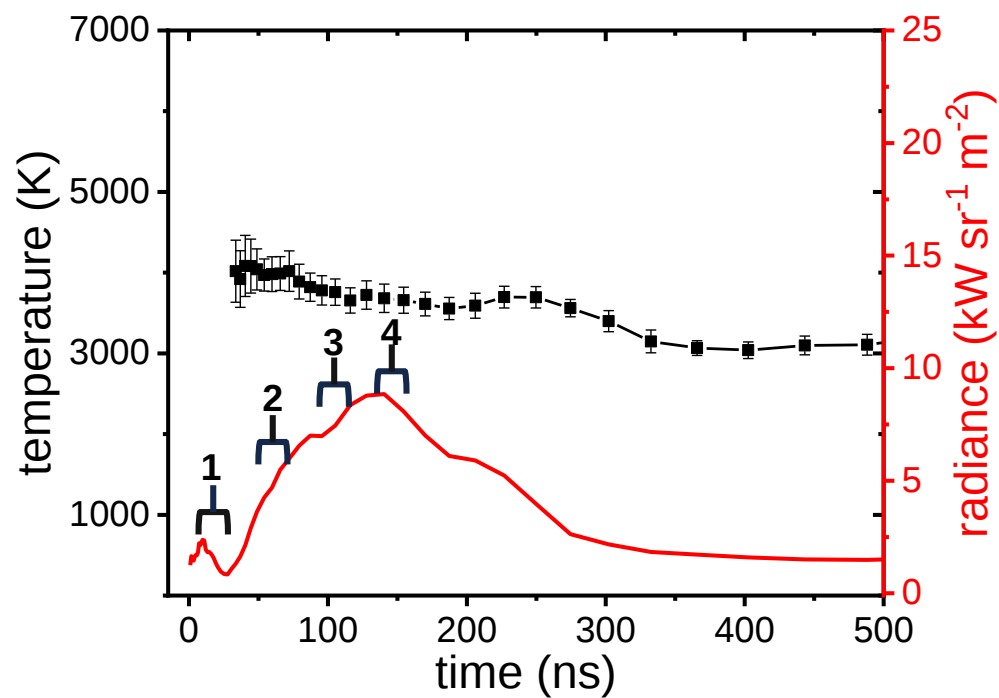
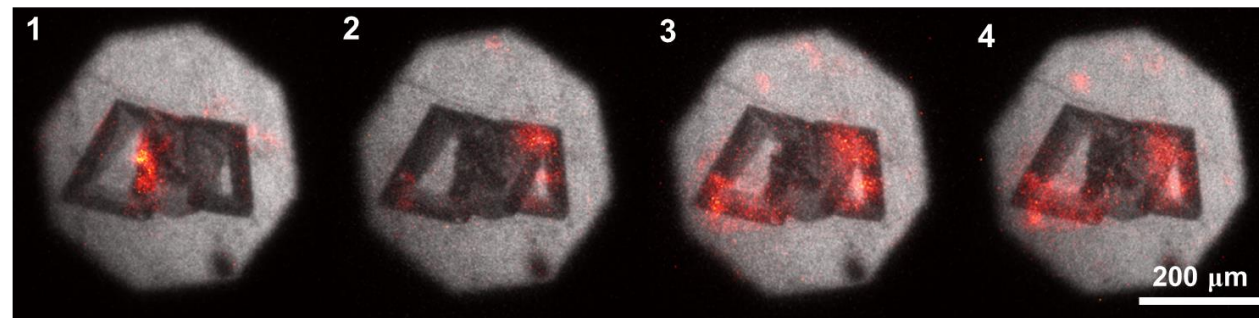
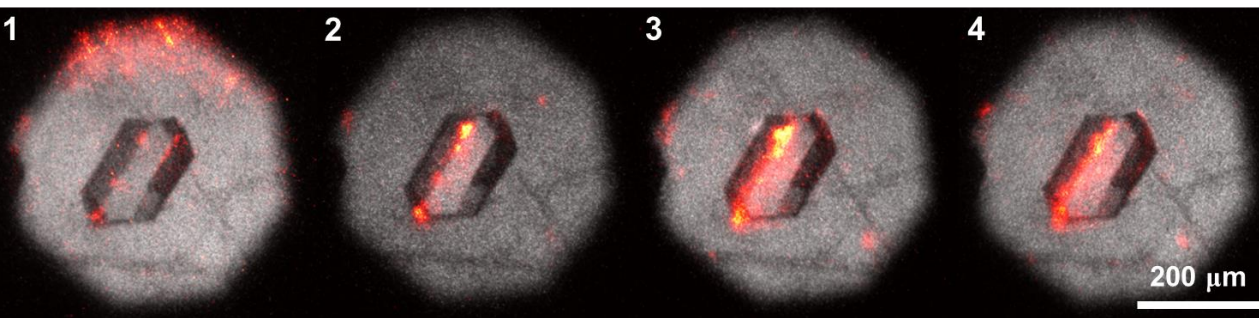
- PDV → Time of flyer impact on polymer ($t=0$)
- Camera → 4 snapshots of emission
- Pyrometer → time-dependent temperatures



Experimentally Observing Hot Spots in Individual HMX Grains

Johnson, B. P., Zhou, X., Ihara, H., Dlott, D. D., *J. Phys. Chem. A* **2020**, *124* (23), 4646-4653.

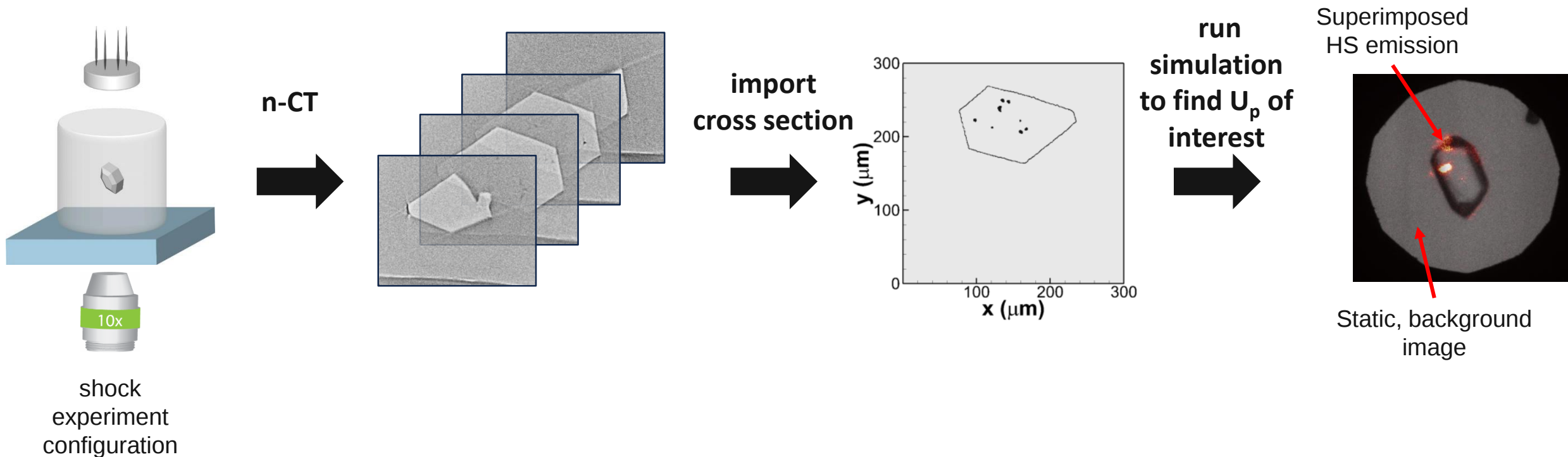
Single vs Defective Crystals



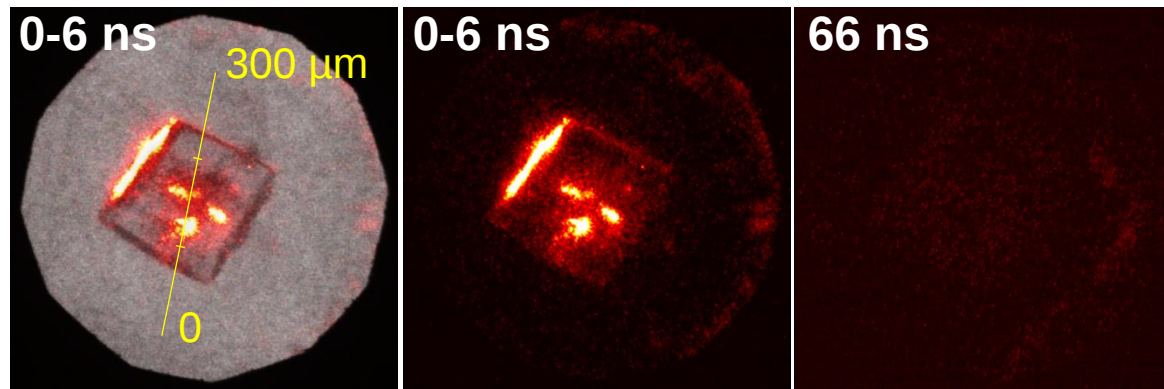
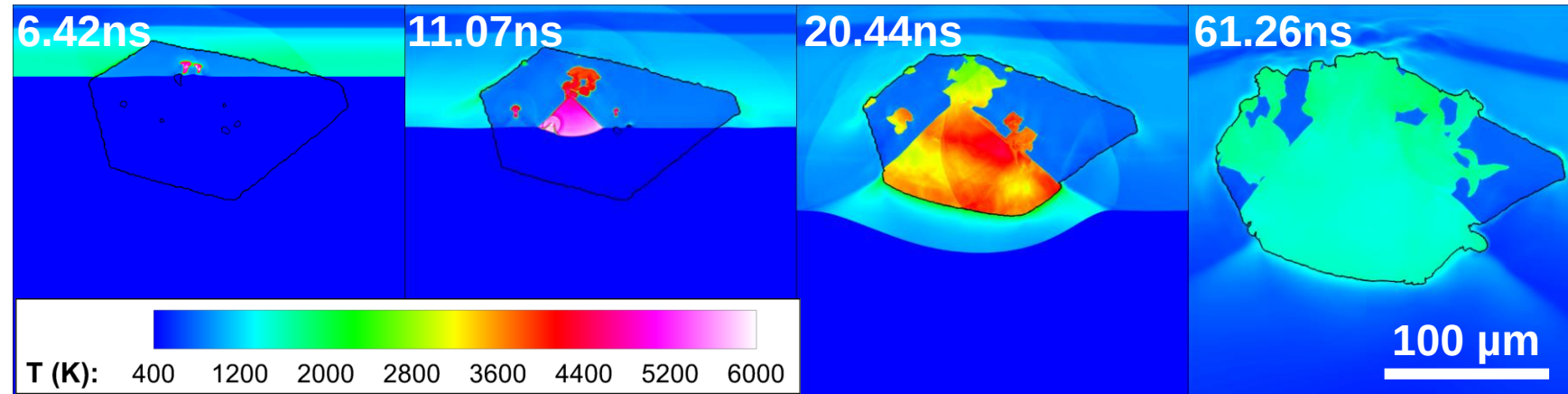
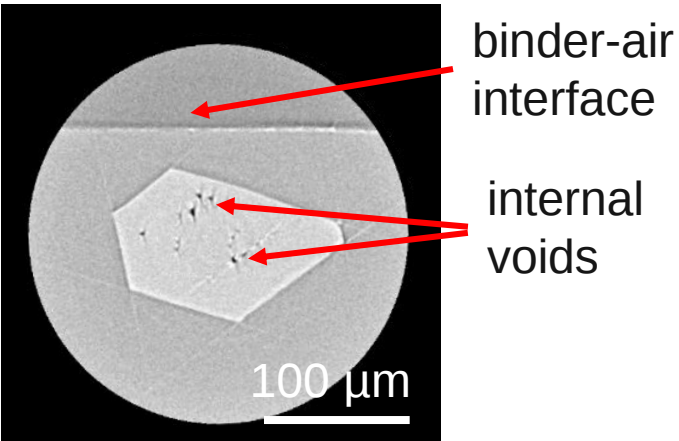
Hot Spot Formation in a Model PBX: Simulations and Experiments

Shobhan Roy, Yen Nguyen, Pratik Das, Prof. H.S. Udaykumar (Iowa)
Belinda P. Johnson, Xuan Zhou, Prof. Dana Dlott (UIUC)

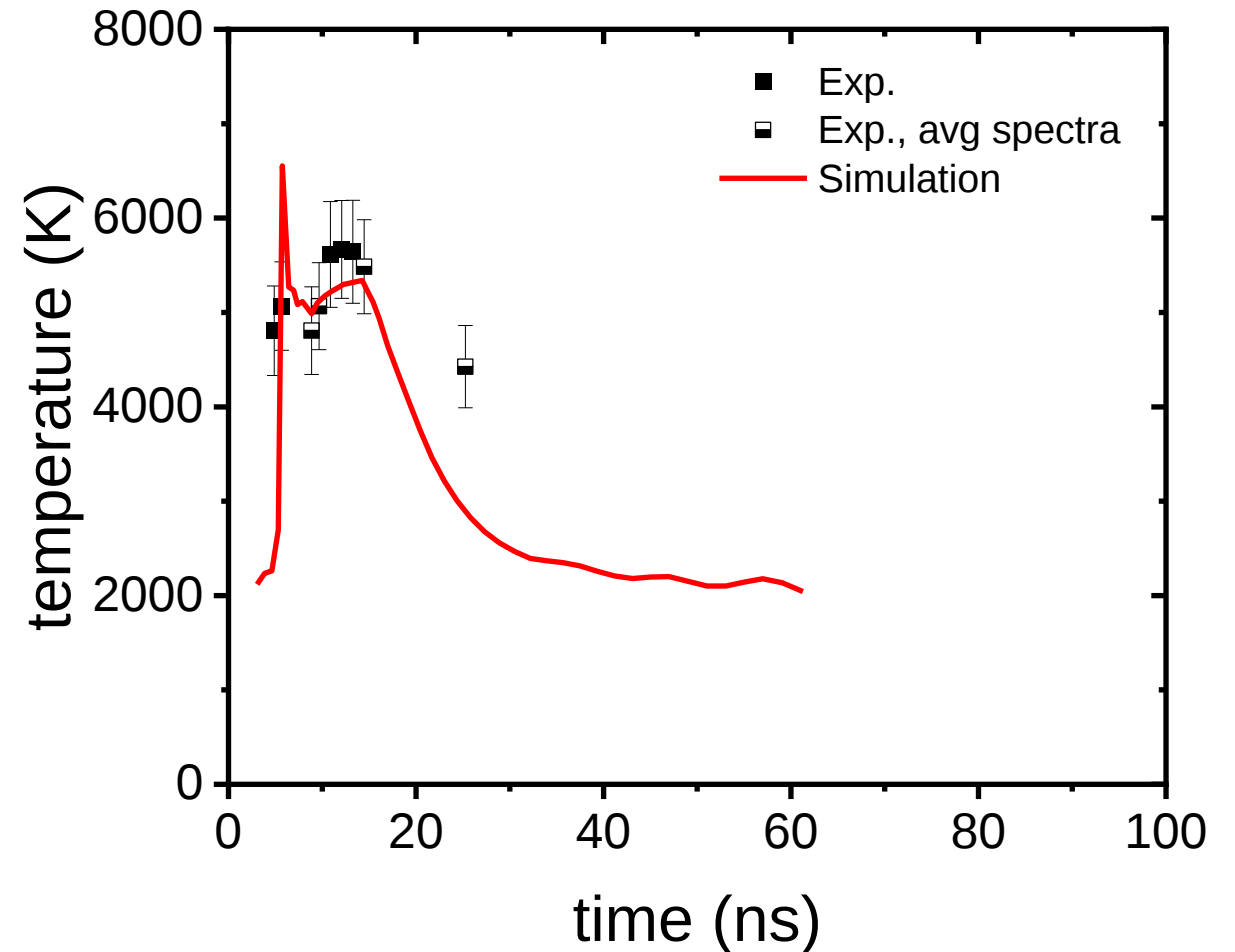
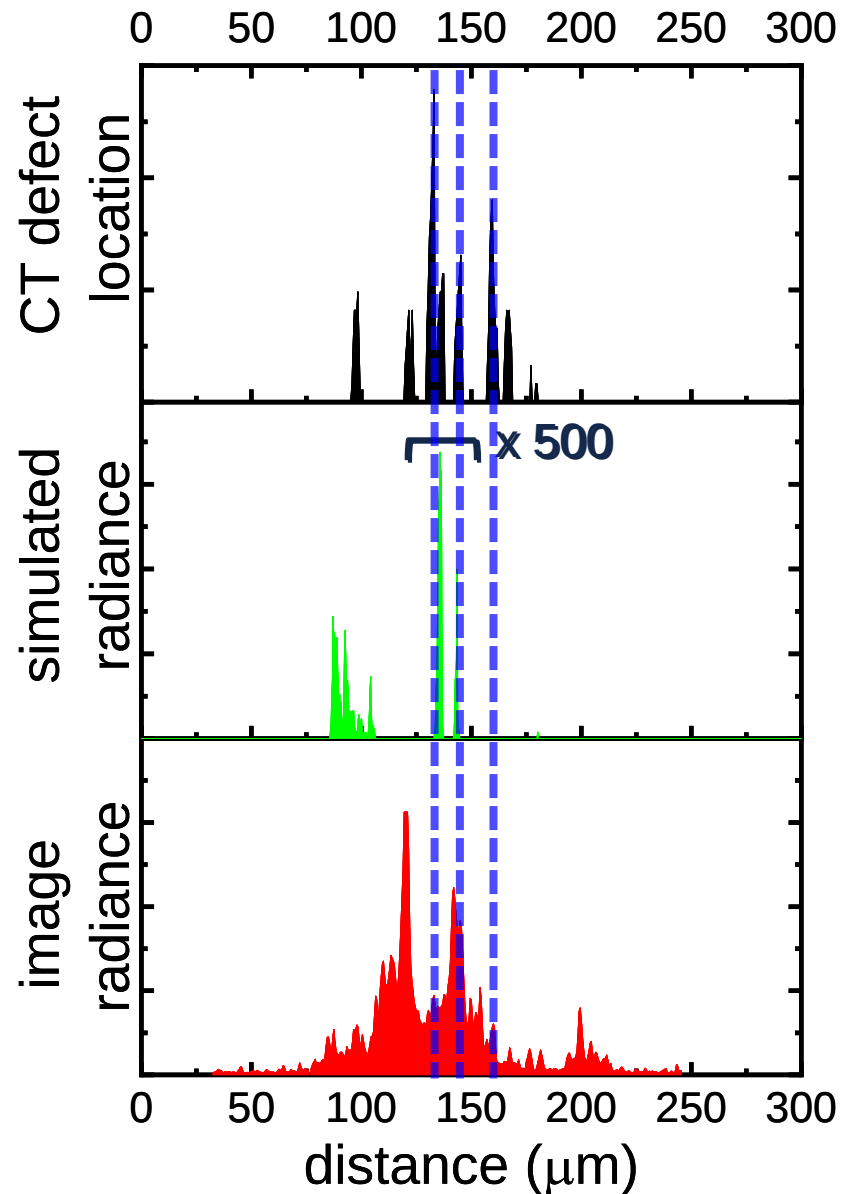
Methodology for Simulating Model PBX



Qualitative HS Formation Comparison

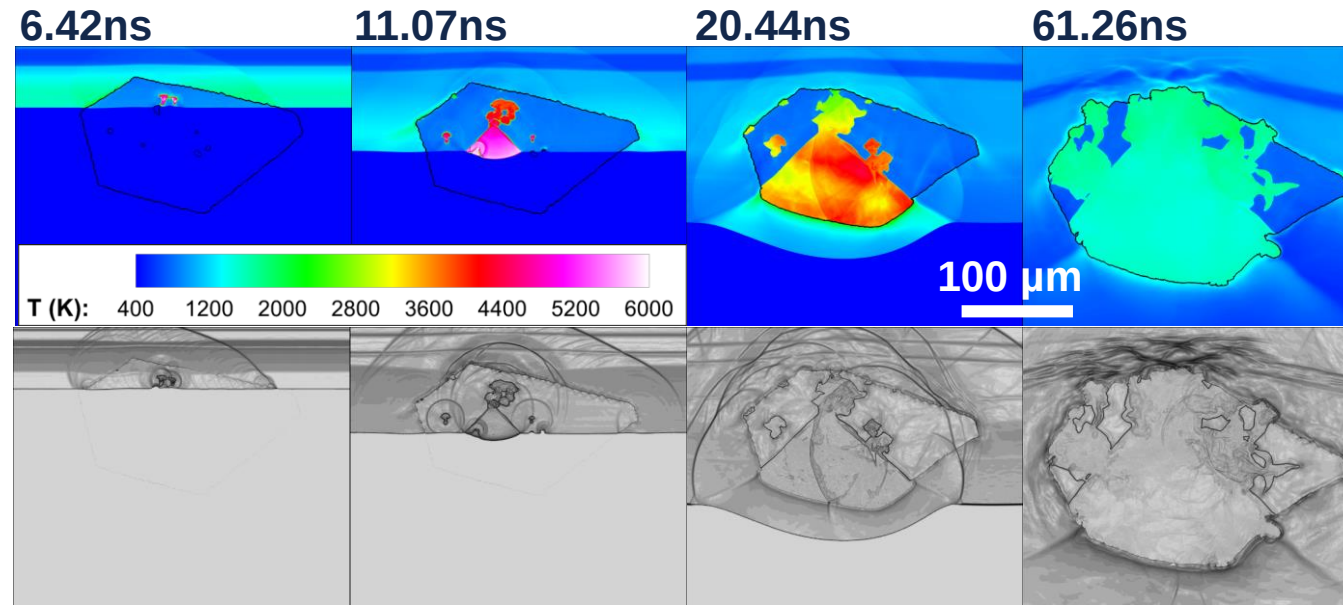


Quantitative HS Temperature Comparison

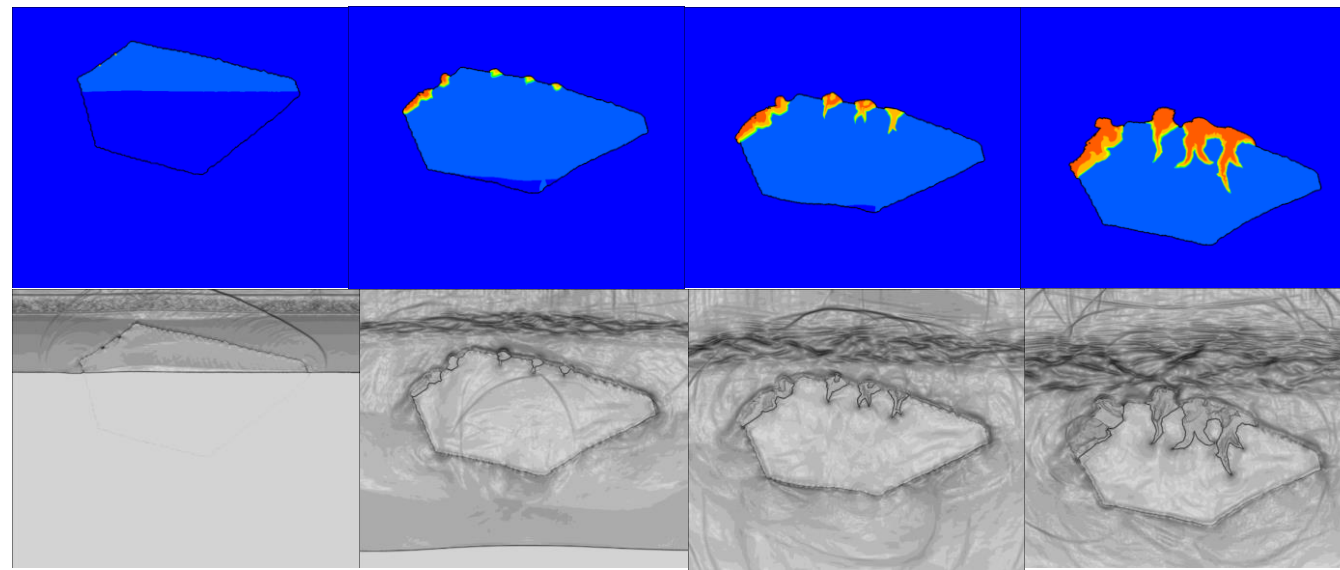


Hot Spot Formation Mechanisms

with internal
voids

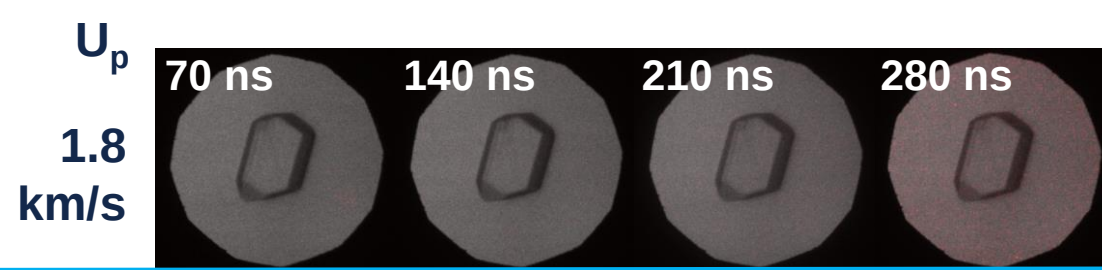


voids
artificially
removed

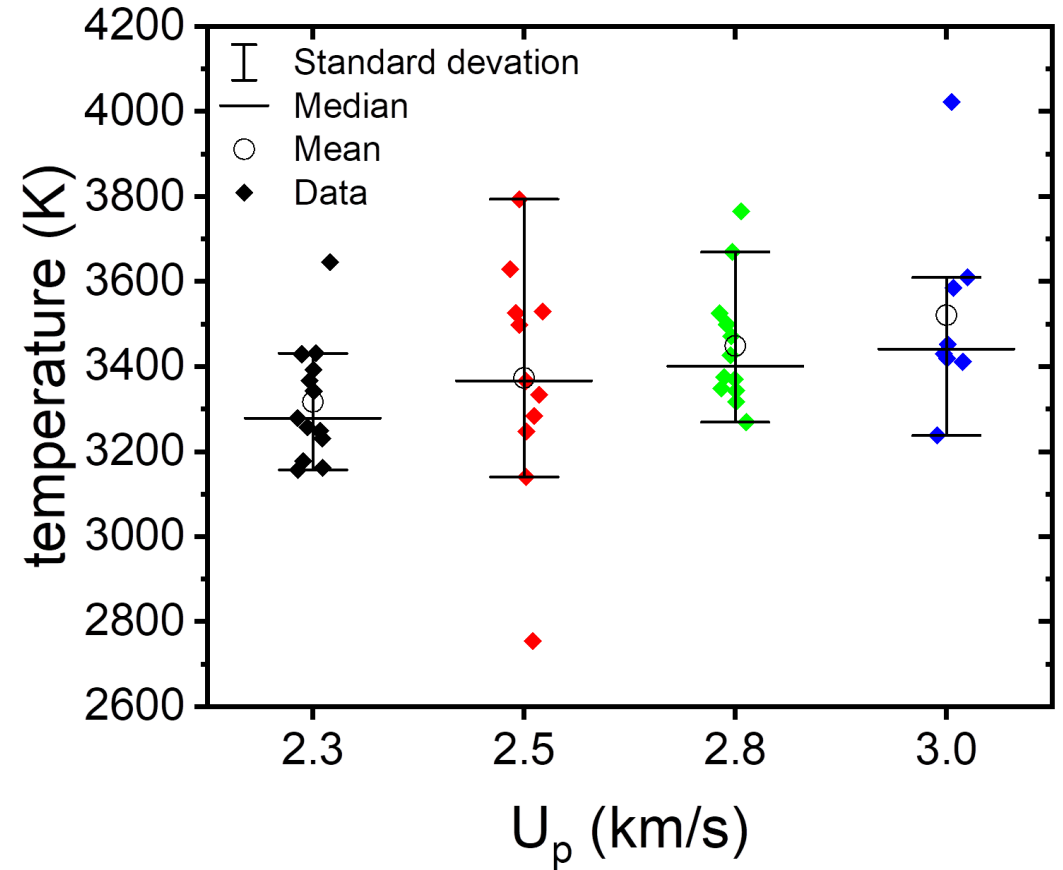
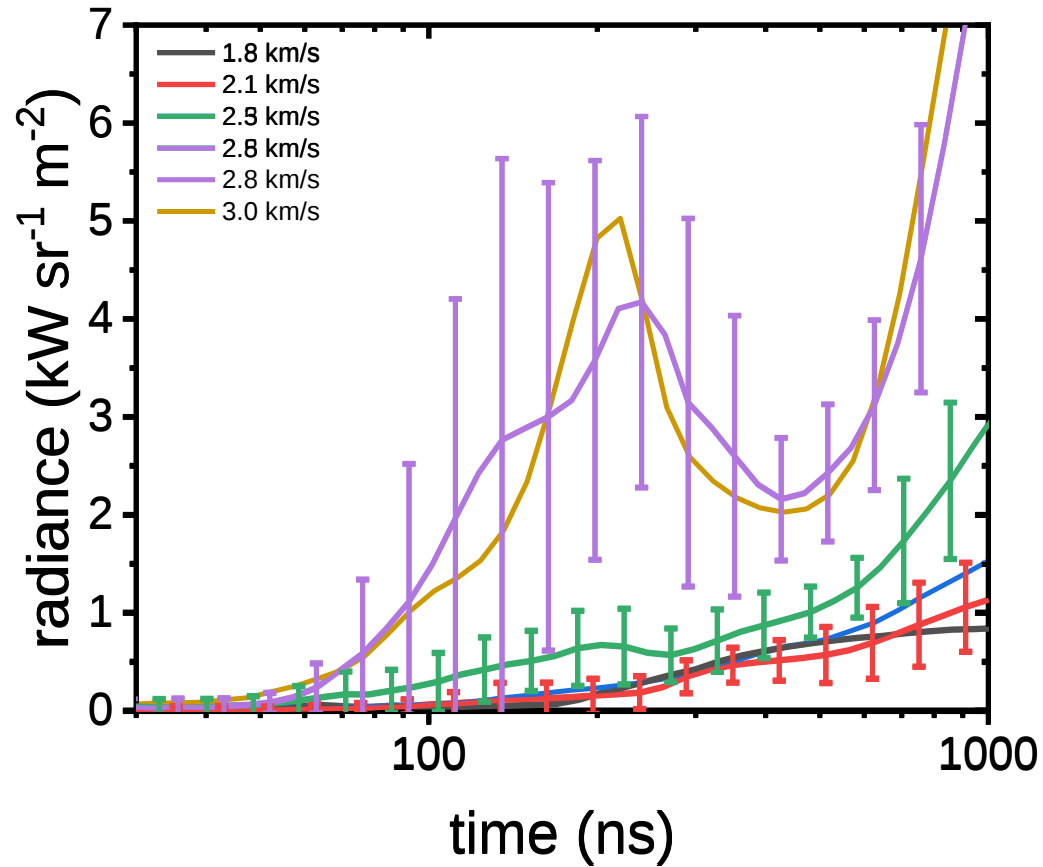


Hot Spot Formation in a Model PBX: Simulations and Experiments

Johnson, B. P., Zhou, X., Ihara, H., Dlott, D. D., *J. Phys. Chem. A* **2021**, *Accepted*.



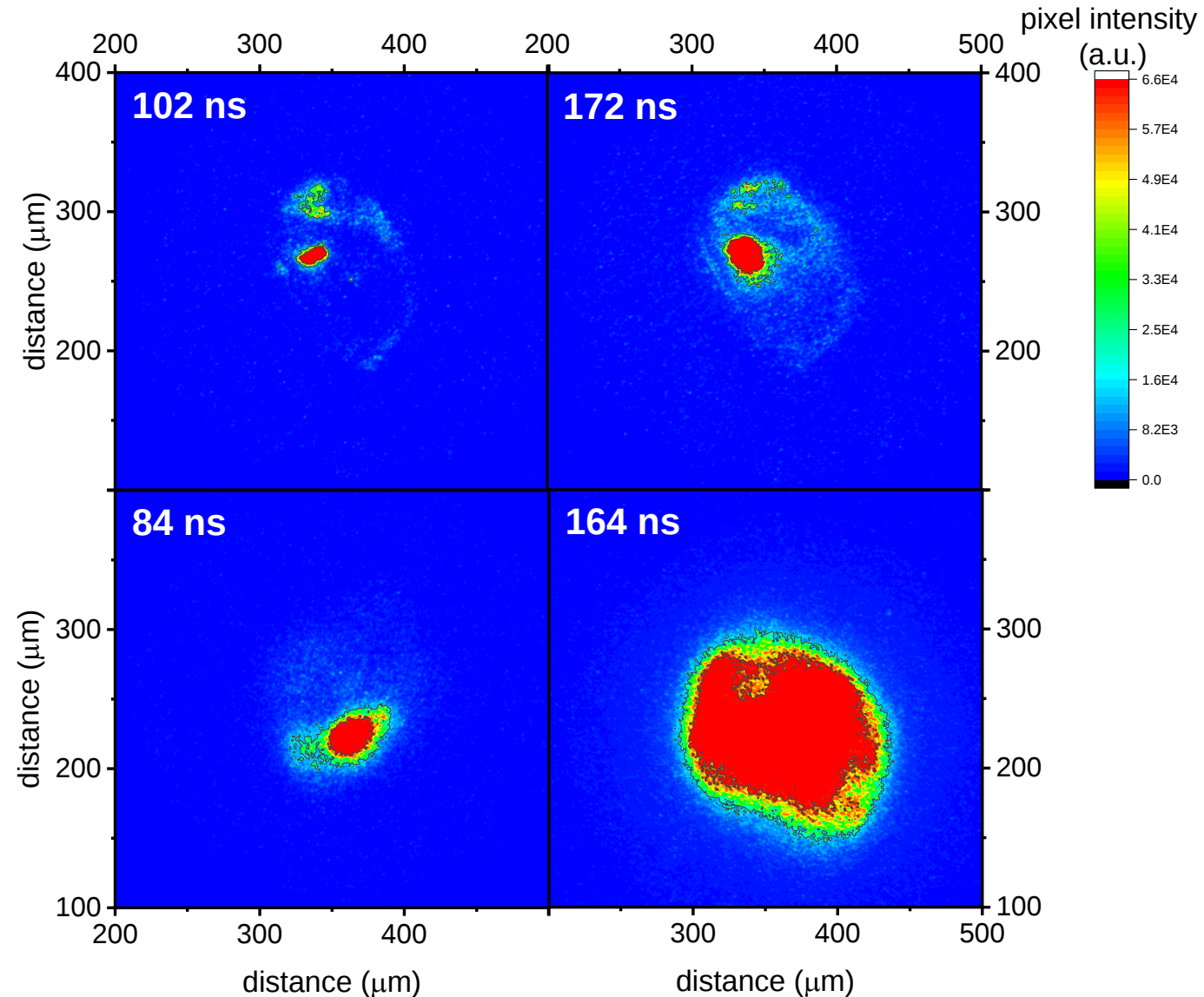
Early Time Pyrometry



Growth Rates of Individual Hot Spots

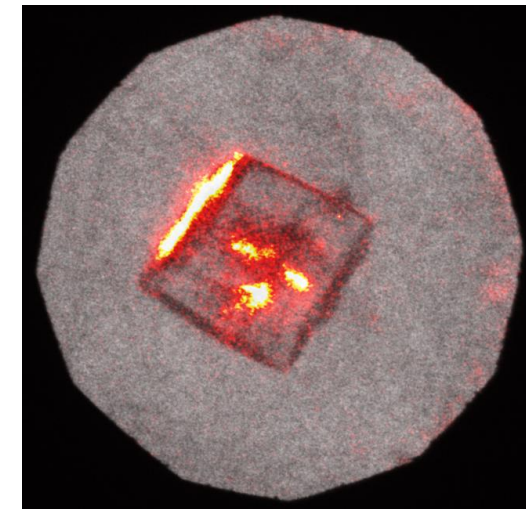
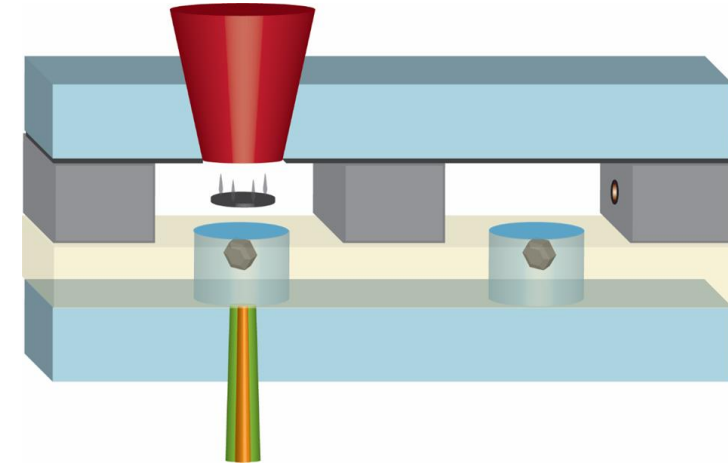
$U_p = 2.3 \text{ km/s}$
 $E_r = 149 \text{ m/s}$

$U_p = 3.0 \text{ km/s}$
 $E_r = 556 \text{ m/s}$



Summary and Future Directions

- Tabletop platform for systematic study of hot spots in model PBXs:
 - Experimentally observe HS formation, location, temperature, and propagation
 - Impact pressure thresholds and growth behavior
- Ongoing Efforts
 - Direct comparison to reactive simulations (Shobhan Roy, Iowa)
 - Quantify HS growth
 - Varying binder
 - Time-resolved temperature maps



Acknowledgements

- Prof. Dlott
- Dr. Xuan Zhou
- Hoya Ihara
- Shobhan Roy & Udaykumar group (Iowa)
- Dr. Will Bassett
- Dlott group



Graduate
Research
Fellowship
Program

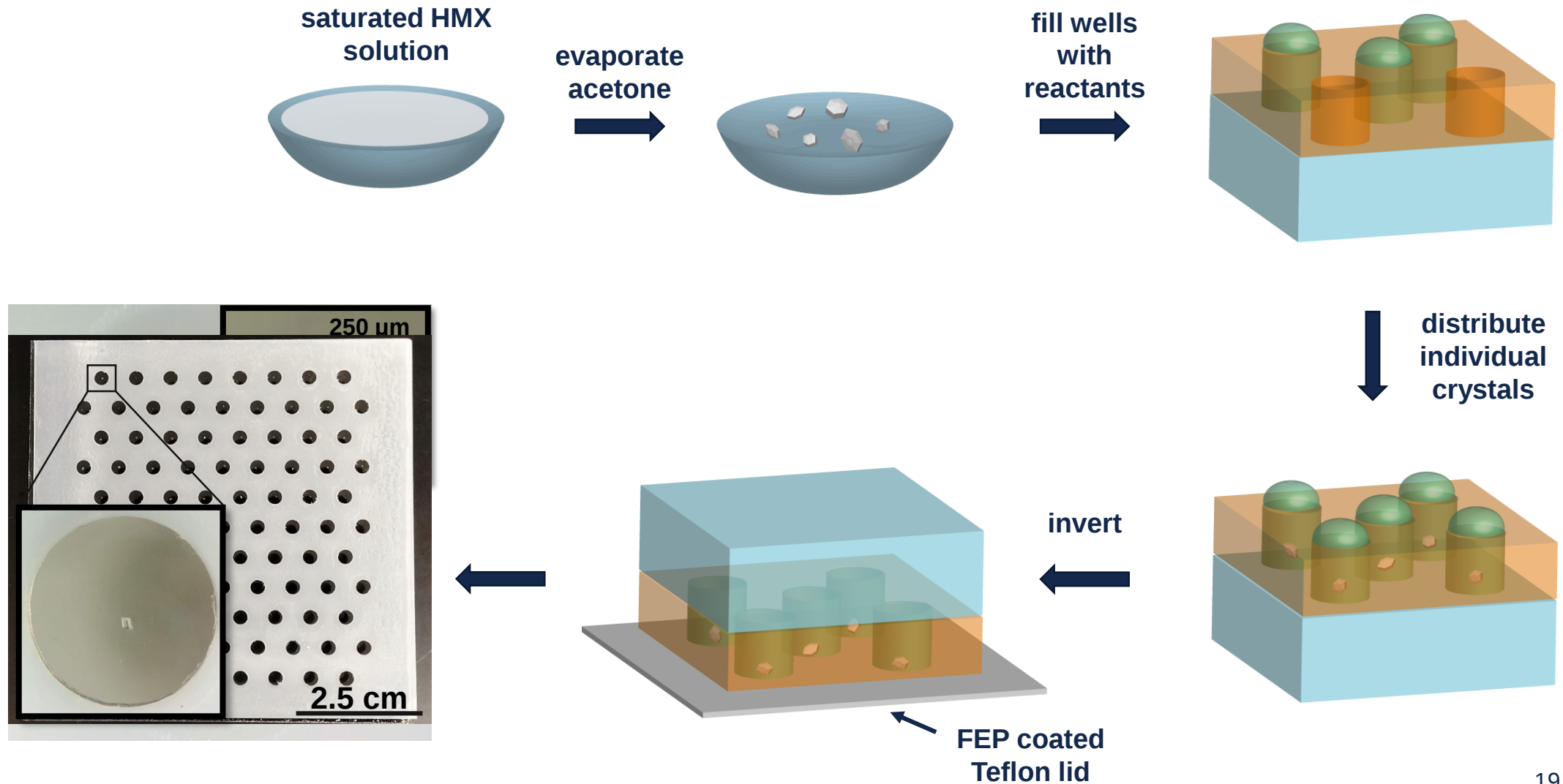


Alfred P. Sloan
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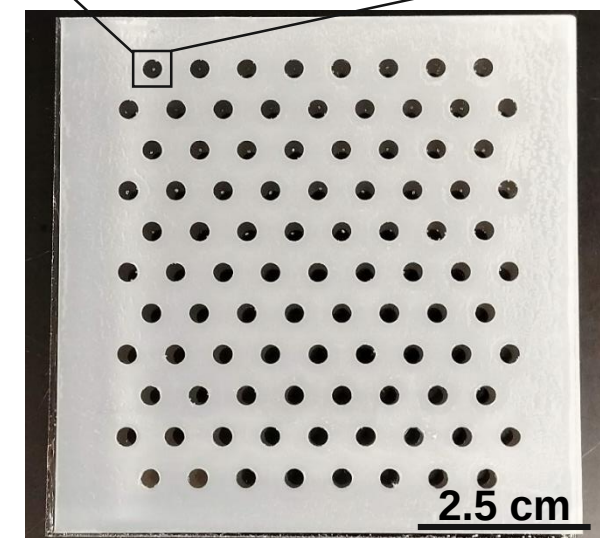
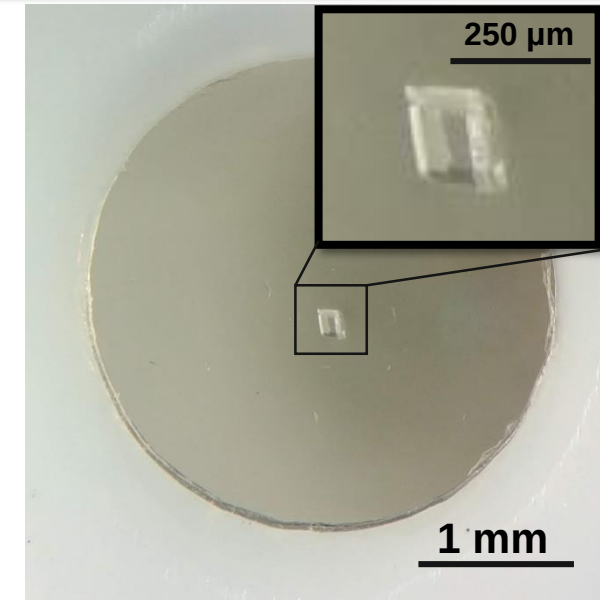
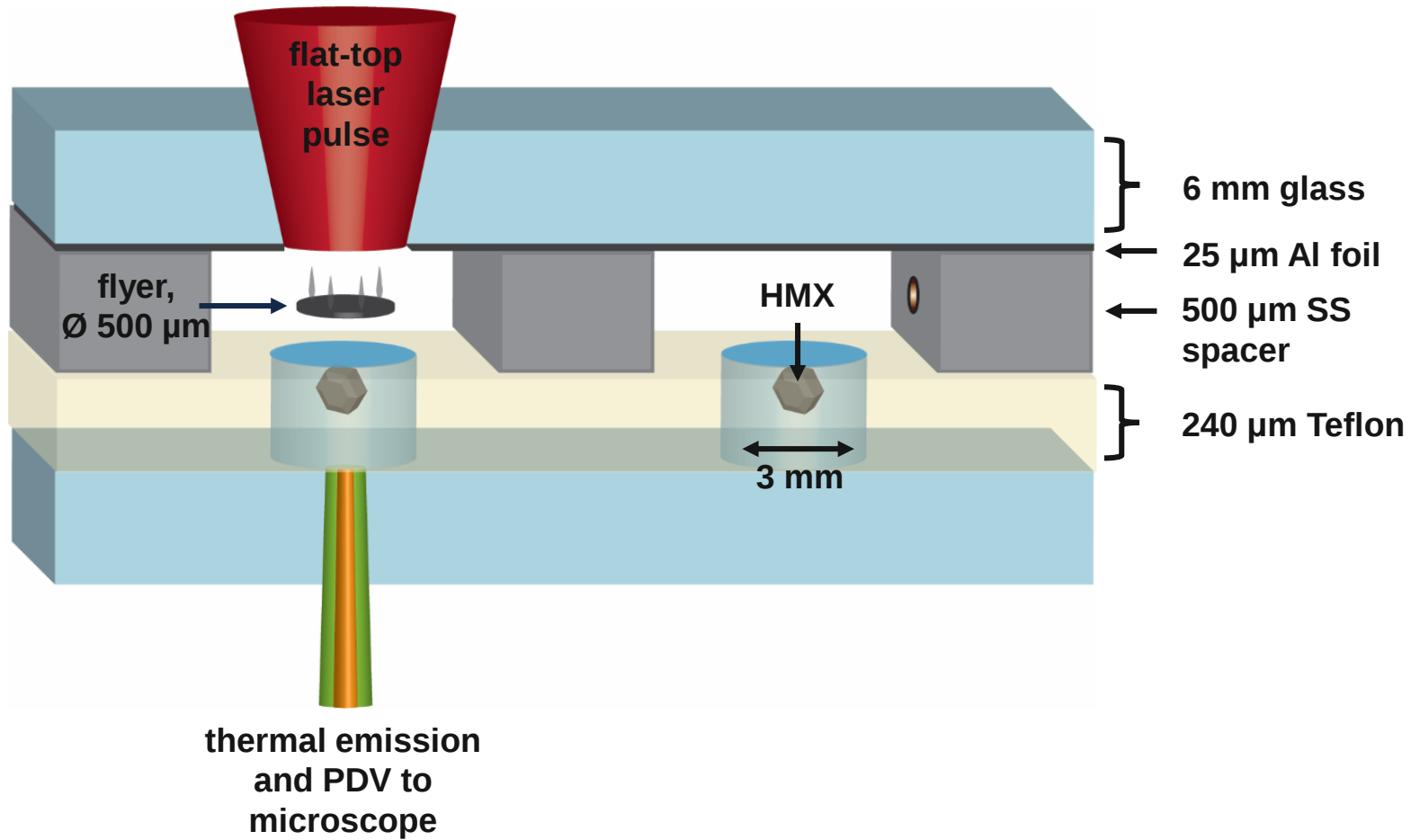


Supplementary Slides

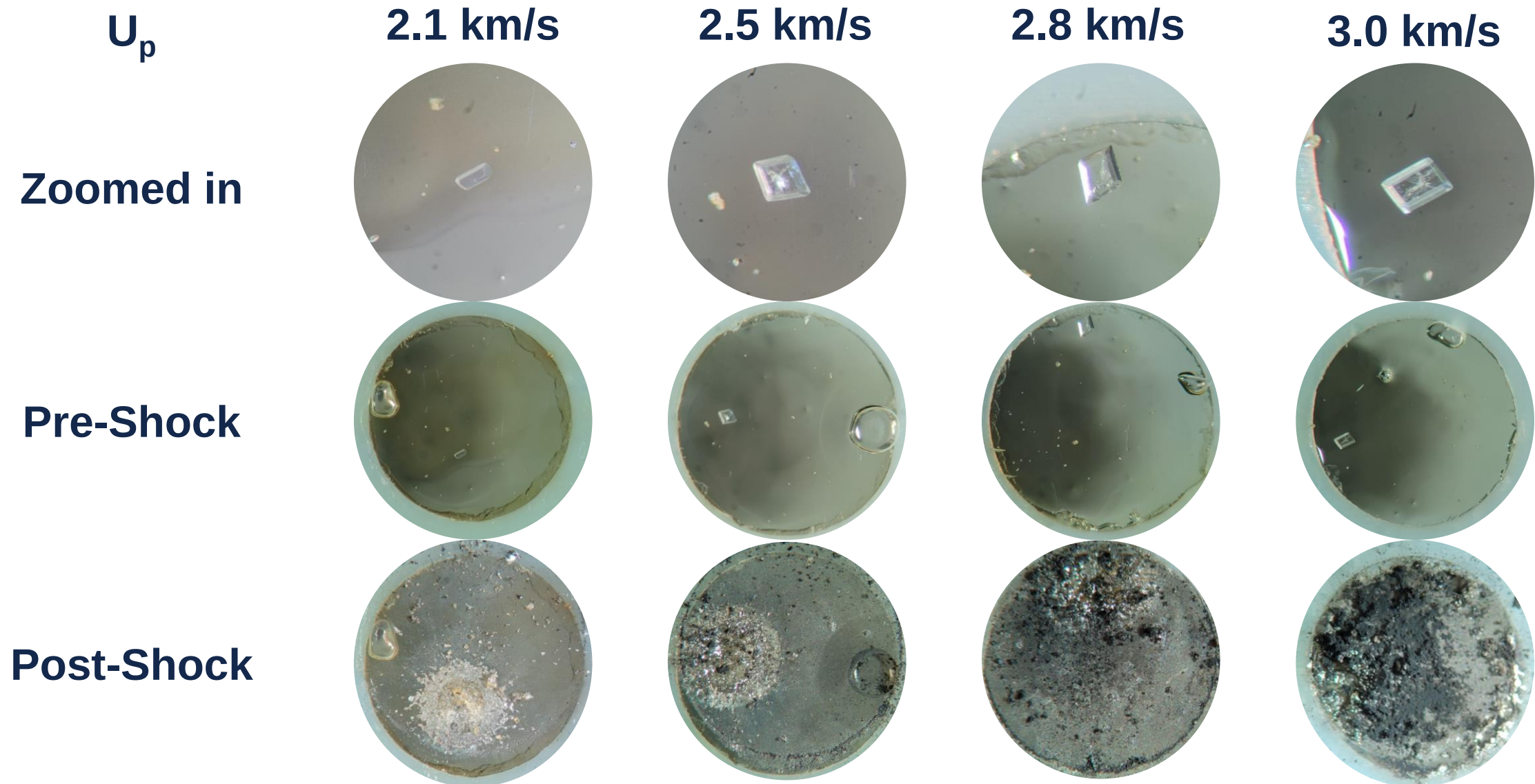
Synthesis of a Model PBX

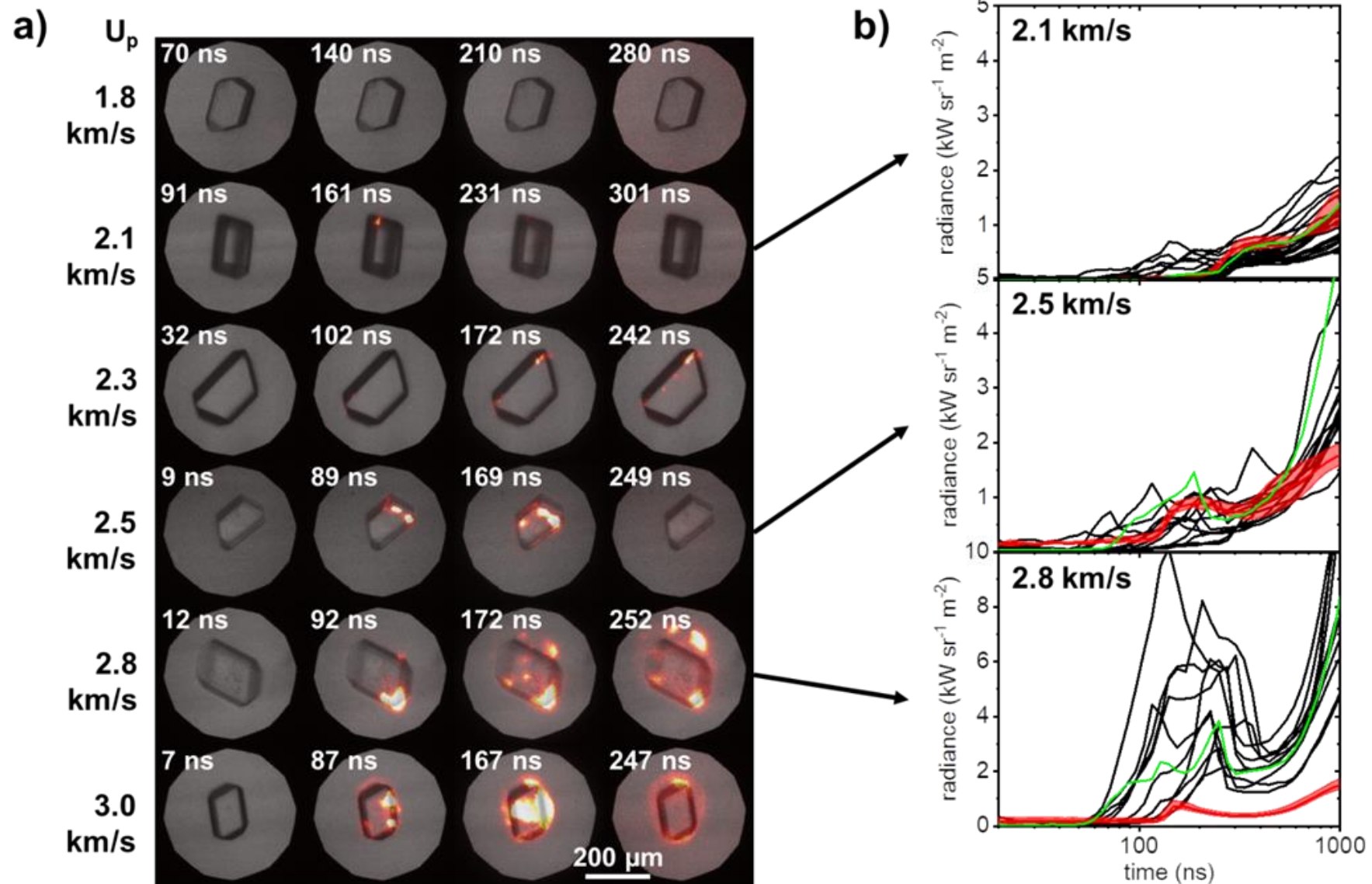


Sample Configuration

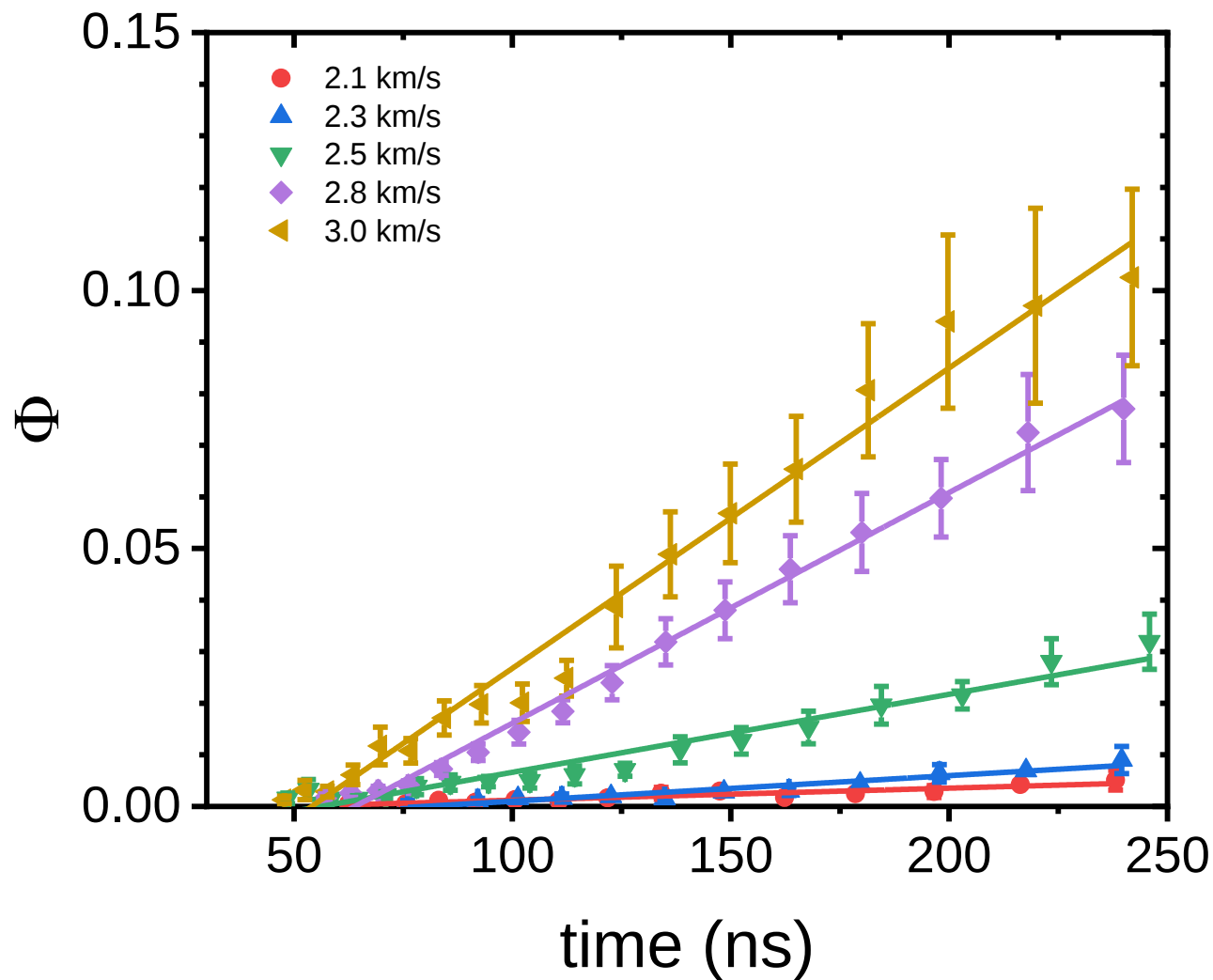


Post-Mortem Images



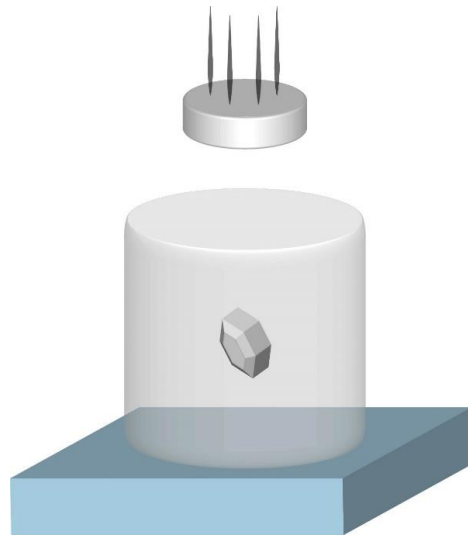


U_p -Dependent Spatially Averaged Emissivity

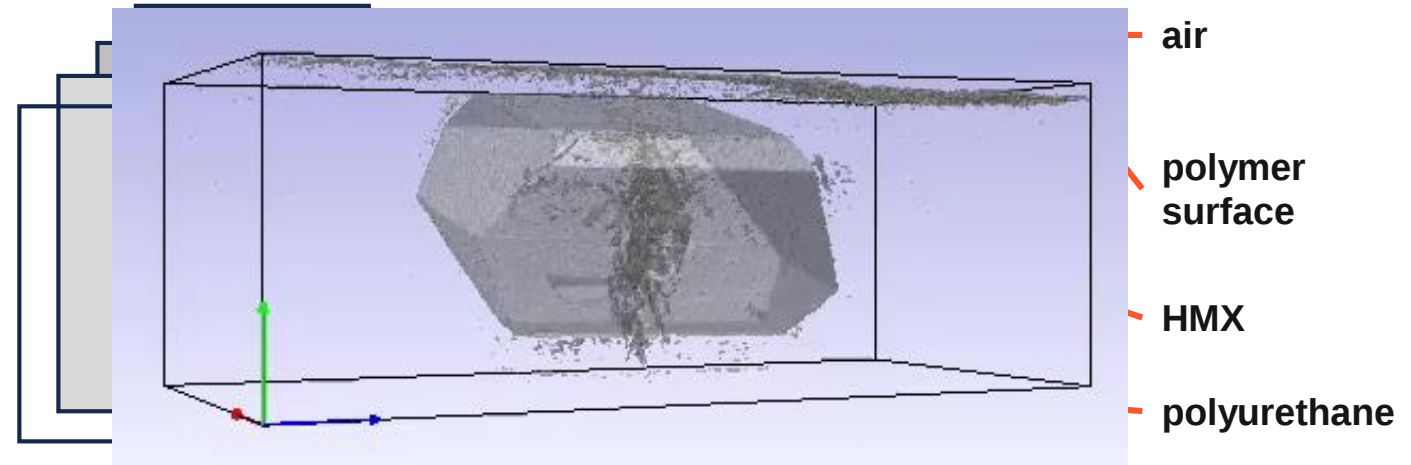


Imaging Configuration

CT scan and
simulation
configuration



cross
sections



shock
experiment
configuration

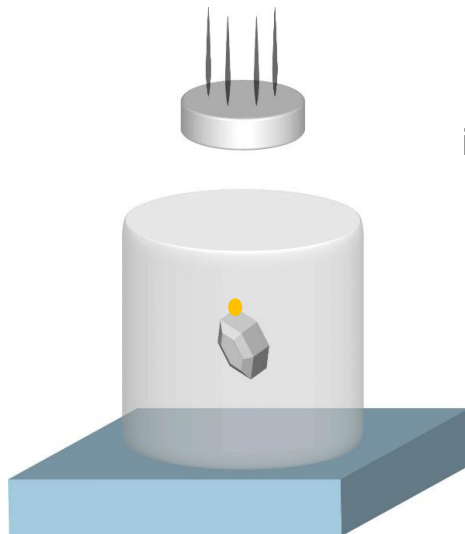
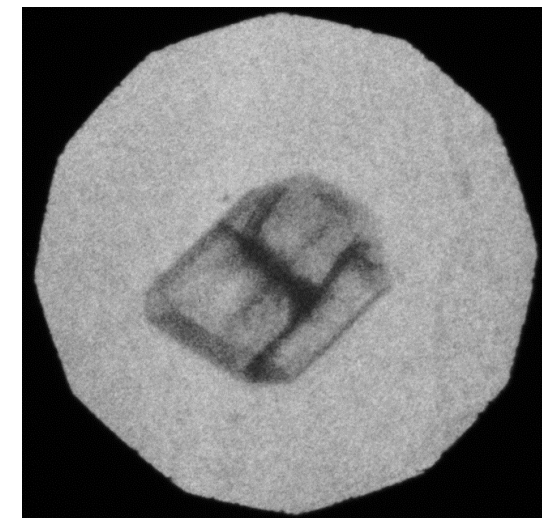
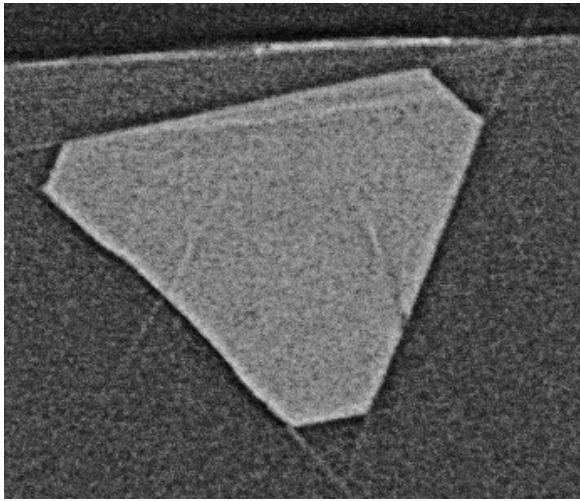


image focused on
crystal top

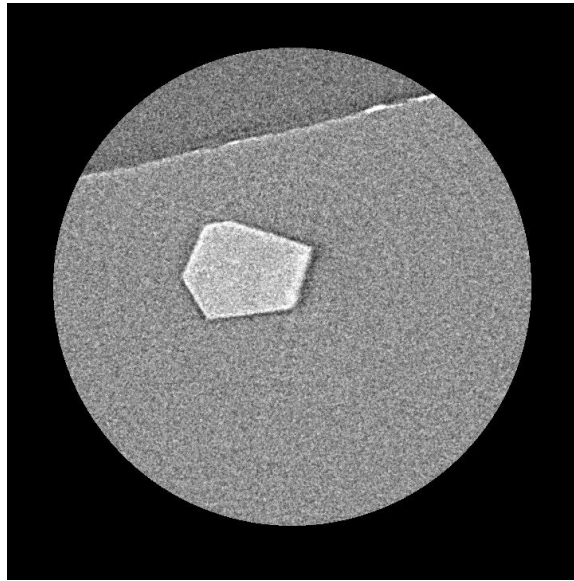


CT Scanned Crystals (Xuan)

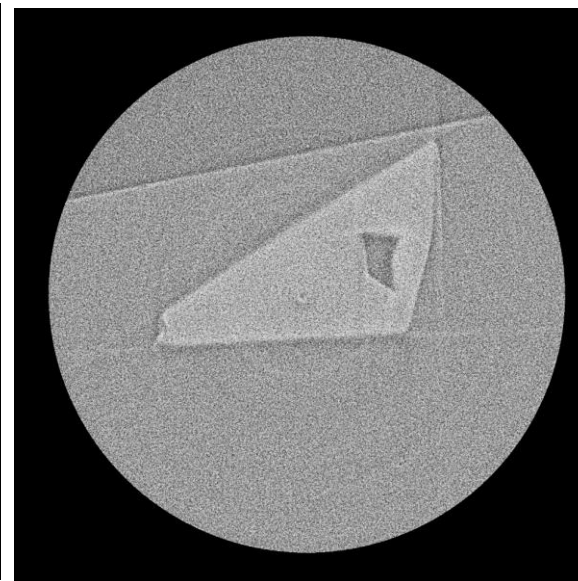
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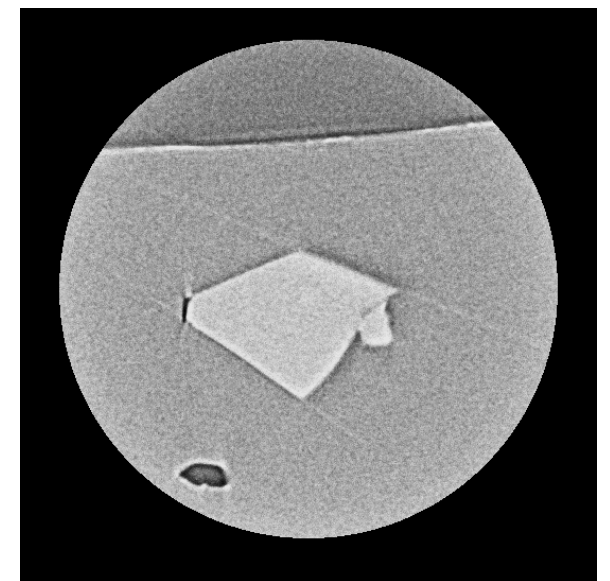
#2



#3



#4



Sample Configuration

